
Električna oprema za merjenje, nadzor in laboratorijsko uporabo - Zahteve za elektromagnetno združljivost (EMC) - 2-2. del: Posebne zahteve - Preskusne konfiguracije, obratovalni pogoji in merila za učinkovitosti za prenosno preskuševalno, merilno opremo in opremo za nadzorovanje, ki se uporablja v nizkonapetostnih distribucijski sistemih

Electrical equipment for measurement, control and laboratory use - EMC requirements - Part 2-2: Particular requirements - Test configurations, operational conditions and performance criteria for portable test, measuring and monitoring equipment used in low-voltage distribution systems (IEC 61326-2-2:2012)

Elektrische Mess-, Steuer-, Regel- und Laborgeräte – EMV-Anforderungen – Teil 2-2: Besondere Anforderungen – Prüfanordnung, Betriebsbedingungen und Leistungsmerkmale für ortsveränderliche Prüf-, Mess- und Überwachungsgeräte für den Gebrauch in Niederspannungs-Stromversorgungsnetzen

Matériel électrique de mesure, de commande et de laboratoire - Exigences relatives à la CEM - Partie 2-2: Exigences particulières - Configurations d'essai, conditions de fonctionnement et critères de performance des matériels portatifs d'essai, de mesure et de surveillance utilisés dans des systèmes de distribution basse tension

Ta slovenski standard je istoveten z: prEN IEC 61326-2-2:2019

ICS:

19.080	Električno in elektronsko preskušanje	Electrical and electronic testing
33.100.01	Elektromagnetna združljivost na splošno	Electromagnetic compatibility in general

oSIST prEN IEC 61326-2-2:2019

en,fr,de

iTeh STANDARD PREVIEW **(standards.iteh.ai)**

[kSIST FprEN IEC 61326-2-2:2020](https://standards.iteh.ai/catalog/standards/sist/a07a30bd-5743-4a7d-803c-4a79b308bd6f/ksist-fpren-iec-61326-2-2-2020)

<https://standards.iteh.ai/catalog/standards/sist/a07a30bd-5743-4a7d-803c-4a79b308bd6f/ksist-fpren-iec-61326-2-2-2020>



COMMITTEE DRAFT FOR VOTE (CDV)

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SECRETARIAT:

United Kingdom

SECRETARY:

Mr Petar Luzajic

OF INTEREST TO THE FOLLOWING COMMITTEES:

TC 77, SC 77A

PROPOSED HORIZONTAL STANDARD:



Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.

FUNCTIONS CONCERNED:

☒ EMC☐ ENVIRONMENT☐ QUALITY ASSURANCE☐ SAFETY☒ SUBMITTED FOR CENELEC PARALLEL VOTING☐ NOT SUBMITTED FOR CENELEC PARALLEL VOTING**Attention IEC-CENELEC parallel voting**

The attention of IEC National Committees, members of CENELEC, is drawn to the fact that this Committee Draft for Vote (CDV) is submitted for parallel voting.

The CENELEC members are invited to vote through the CENELEC online voting system.

This document is still under study and subject to change. It should not be used for reference purposes.

Recipients of this document are invited to submit, with their comments, notification of any relevant patent rights of which they are aware and to provide supporting documentation.

TITLE:

Electrical equipment for measurement, control and laboratory use – EMC requirements – Part 2-2: Particular requirements – Test configurations, operational conditions and performance criteria for portable test, measuring and monitoring equipment used in low-voltage distribution systems

PROPOSED STABILITY DATE: 2023

NOTE FROM TC/SC OFFICERS:

CONTENTS

1		
2	FOREWORD	3
3	1 Scope	5
4	2 Normative references	5
5	3 Terms and definitions	5
6	4 General	6
7	5 EMC test plan	6
8	5.1 General	6
9	5.2 Configuration of EUT during testing	6
10	5.3 Operation conditions of EUT during testing	8
11	5.4 Specification of functional performance	8
12	5.5 Test description	8
13	6 Immunity requirements	8
14	6.1 Conditions during the tests	8
15	6.2 Immunity test requirements	8
16	6.3 Random aspects	9
17	6.4 Performance criteria	9
18	7 Emission requirements	9
19	8 Test results and test report	9
20	9 Instructions for use	9
21		
22	Figure 101 – Test set-up for portable test measuring and monitoring equipment based	
23	on IEC 61000-4-3	7
24	Figure 102 – Example of connection details for voltage measurements	7
25	Figure 103 – Example of connection details for current measurements	8
26		

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS –

Part 2-2: Particular requirements – Test configurations, operational conditions and performance criteria for portable test, measuring and monitoring equipment used in low-voltage distribution systems

FOREWORD

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International Standard IEC 61326-2-2 has been prepared by subcommittee 65A: System aspects, of IEC technical committee 65: Industrial-process measurement, control and automation.

This third edition cancels and replaces the second edition published in 2012. This edition constitutes a technical revision.

The main technical changes with regard to the previous edition are as follows:

- Update with respect to IEC 61326-1:2012.

83 The text of this standard is based on the following documents:

FDIS	Report on voting
65A/642/FDIS	65A/653/RVD

84
85 Full information on the voting for the approval of this standard can be found in the report on
86 voting indicated in the above table.

87 This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

88 This part of IEC 61326 series is to be used in conjunction with IEC 61326-1:20xx and follows
89 the same numbering of clauses, subclauses, tables and figures.

90 When a particular subclause of IEC 61326-1 is not mentioned in this part, that subclause
91 applies as far as is reasonable. When this standard states “addition”, “modification” or
92 “replacement”, the relevant text in IEC 61326-1 is to be adapted accordingly.

93 NOTE The following numbering system is used:

- 94 – subclauses, tables and figures that are numbered starting from 101 are additional to those in
95 IEC 61326-1;
96 – unless notes are in a new subclause or involve notes in IEC 61326-1, they are numbered starting from 101
97 including those in a replaced clause or subclause;
98 – additional annexes are lettered AA, BB, etc.

99 A list of all parts of IEC 61326 series, under the general title *Electrical equipment for*
100 *measurement, control and laboratory use – EMC requirements* can be found on the IEC
101 website.

[kSIST FprEN IEC 61326-2-2:2020](https://standards.iteh.ai/catalog/standards/sist/a07a30bd-5743-4a7d-803c-4a79b308b466/ksist-pr-en-iec-61326-2-2-2020)

102 The committee has decided that the contents of this publication will remain unchanged until
103 the stability date indicated on the IEC web site under “<http://webstore.iec.ch>” in the data
104 related to the specific publication. At this date, the publication will be

- 105 • reconfirmed,
106 • withdrawn,
107 • replaced by a revised edition, or
108 • amended.

109

ELECTRICAL EQUIPMENT FOR MEASUREMENT, CONTROL AND LABORATORY USE – EMC REQUIREMENTS –

Part 2-2: Particular requirements – Test configurations, operational conditions and performance criteria for portable test, measuring and monitoring equipment used in low-voltage distribution systems

1 Scope

In addition to the scope of IEC 61326-1, this part of IEC 61326 specifies more detailed test configurations, operational conditions and performance criteria for equipment covered by Annex A of IEC 61326-1 which is:

- used for testing, measuring or monitoring of protective measures in low-voltage distribution systems, and;
- powered by battery and/or from the circuit measured, and
- portable.

Examples of such EUT include, but are not limited to, voltage detectors, insulation testers, earth continuity testers, earth resistance testers, leakage current clamps, loop impedance testers, “residual-current-device-testers” (RCD-testers) and phase sequence testers as defined in IEC 61557.

NOTE Particular EMC requirements for equipment covered by IEC 61557-8 and IEC 61557-9 are given in IEC 61326-2-4.

The manufacturer specifies the environment for which the product is intended to be used and/or selects the appropriate test level specifications of IEC 61326-1.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

Clause 2 of IEC 61326-1:20xx applies, except as follows:

Addition:

IEC 61326-1:20xx, *Electrical equipment for measurement, control and laboratory use – EMC requirements – Part 1: General requirements*

IEC 61557 (all parts), *Electrical safety in low voltage distribution systems up to 1 000 V a.c. and 1 500 V d.c. – Equipment for testing, measuring or monitoring of protective measures*

3 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 61326-1 and IEC 60050-161 apply.

4 General

Clause 4 of IEC 61326-1:20xx applies.

5 EMC test plan**5.1 General**

Subclause 5.1 of IEC 61326-1:20xx applies.

5.2 Configuration of EUT during testing

Subclause 5.2 of IEC 61326-1:20xx applies, except as follows:

Addition:

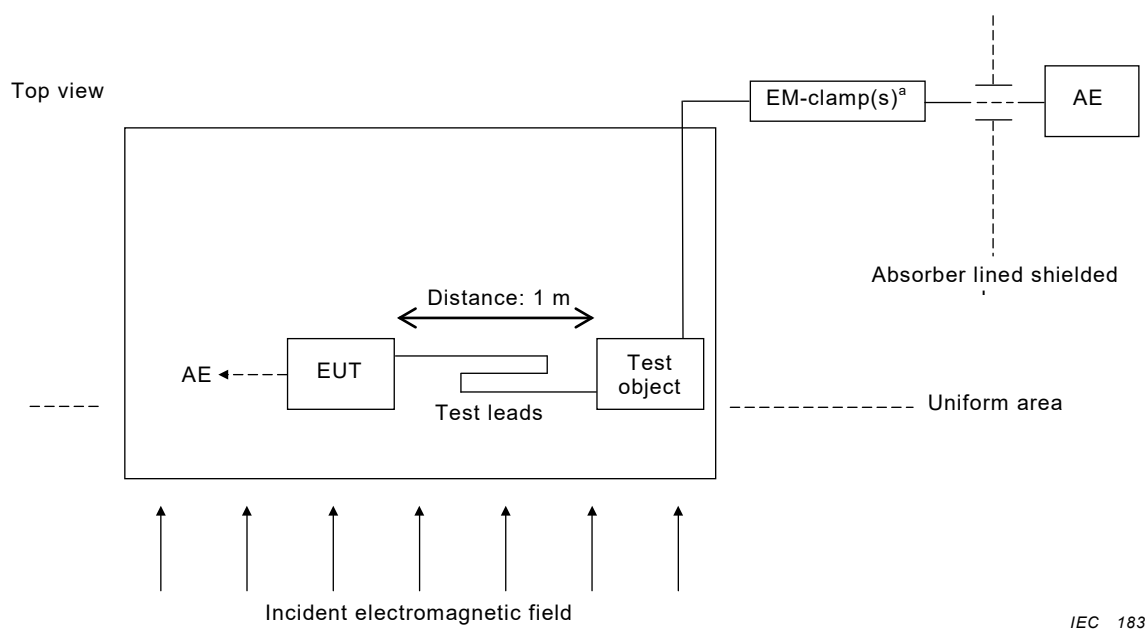
5.2.4.101 Test and measurement I/O ports

Electrostatic discharge shall be applied to the mated connector or the shield of the unmated port, but not to the inner pins of shielded port or cable connectors (for example, BNC, D-subminiature, GPIB, RS232, USB, etc.).

For the test according to IEC 61000-4-3 the following conditions shall be met. Test and measurement ports shall be connected with test leads recommended or supplied with the EUT. Where the test leads are unspecified, typical test leads shall be used. The test leads shall be connected and arranged in a typical configuration for each operation mode, according to Figure 101.

If the test leads recommended or supplied are longer than 1 m, each one should be bundled so that the test object is in a horizontal distance of 1 m to the EUT.

The test leads shall be arranged 0,1 m apart in a horizontal position on the test table.



IEC 1835/12

^a EM-clamp(s) (if necessary).

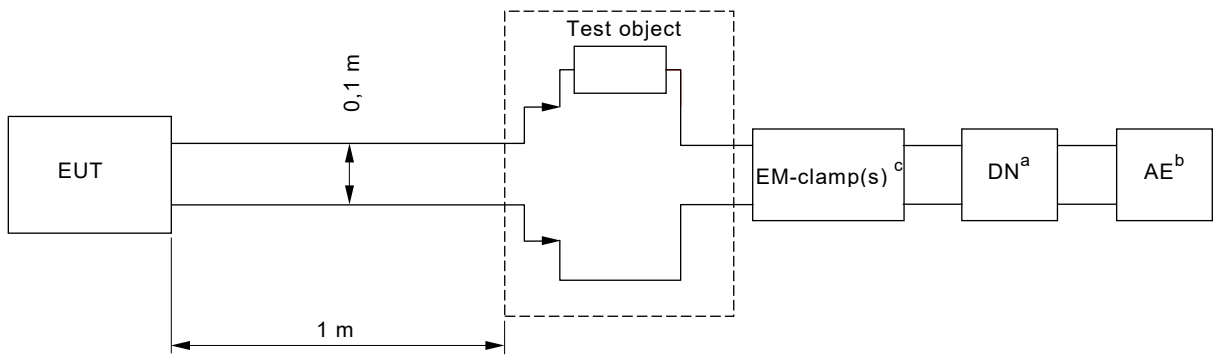
Figure 101 – Test set-up for portable test, measuring and monitoring equipment based on IEC 61000-4-3

Auxiliary equipment (AE) required for generating or monitoring the test object signal shall be connected according to Figure 101 via EM-clamps if necessary as described in IEC 61000-4-6, A.3.

<https://standards.iteh.ai/catalog/standards/sist/a07a30bd-5743-4a7d-803c-4a9b0d015f1e/iec-61326-2-2019>

Voltage measurements shall be made with a $1\,000\,\Omega \pm 100\,\Omega$ resistor (test object) connected in series with one of the test leads as shown in Figure 102.

For other measurements, the test object shall be specified by the manufacturer and documented in the test report.



IEC 1836/12

^a Decoupling network (if necessary).

^b For example, voltage source.

^c EM-clamp(s) (if necessary).

Figure 102 – Example of connection details for voltage measurements

Current measurements shall be made with a $100\,\Omega \pm 10\,\Omega$ resistor (test object) connected in parallel with the test leads as shown in Figure 103.